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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(Use as many sheets as necessary)</i>				Application Number	10/588,965 - Conf. #3961
				Filing Date	August 10, 2006
				First Named Inventor	Mitsunori TANAKA
				Art Unit	2612
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	1248-0892PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> ( <i>if known</i> )	MM-DD-YYYY		
AA*	US-2003/0120742-A1	06-26-2003	Ohgami et al.		
AB*	US-6,084,863-A	07-04-2000	Hori et al.		

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>4</sup>
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> ( <i>if known</i> )	MM-DD-YYYY			
BA	JP-2001-177462-A	06-29-2001				ABS
BB	JP-11-88224-A	03-30-1999				ABS
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NON PATENT LITERATURE DOCUMENTS					
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Examiner Signature	/Amanuel Lebassi/	Date Considered	04/08/2009
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CG/clb

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